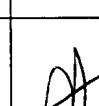
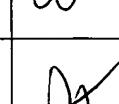


Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/847,606	PECK ET AL.
	Examiner	Art Unit
	Quoc A. Tran	2176

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (US-PAT, US-PGPUB) see Search Histoty Printout	10/14/2005	
IEEE DataBasesee Search Histoty Printout	10/14/2005	
Stic DataBasesee Search Histoty Printout	10/14/2005	
IIP.com DataBase see Search Histoty Printout	10/14/2005	
Scirus DataBasesee Search Histoty Printout	10/14/2005	
ACM DataBasesee Search Histoty Printout	10/14/2005	
update search see seach history pritnout	3/23/2006	

Search Notes				Application No.	Applicant(s)	
				09/847,606	PECK ET AL.	
				Examiner	Art Unit	
				Quoc A. Tran	2176	

SEARCHED			
Class	Subclass	Date	Examiner
715	512	5/21/04	QAT
	590.1		
	591.1		
	522		
709	201		
	217		
	218		
	225		
345	660		
707	9,10		
	102		
705	10	↓	↓
updated above 1/18/05 QAT			
updated above 6/9/05 QAT			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
INVENTOR SEARCH CROSS REF double patent US - PAT US - PGPUB	5/21/04	QAT
EPO SPO DEQUEANT IBM - TDB		
INTERNET P6W3 + ETC PERSONAL digests	↓	↓
update above	1/18/05	QAT
update above	6/9/05	QAT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner